

Topics of the Third International DCC Conference

- 1 Data Handling / DCC Toolbox / Human Readable
 - 1.1 Extraction of Content from the DCC
 - 1.2 DCC-Related Tools
 - 1.2.1 GEMIMEG-Tool
 - 1.2.2 Tools from GEMIMEG Consortia
 - 1.2.3 Human Readable
 - 1.2.4 Middleware
 - 1.2.5 Other Tools
- 2 DCC and Accreditation
 - 2.1 Signatures and Security Mechanisms
- 3 DCC Infrastructure
 - 3.1 Necessities for the Implementation of a DCC Infrastructure
- 4 Different DCC Approaches
 - 4.1 PDF Approach
 - 4.2 Other XML Specifications
 - 4.3 Other Expressions
- 5 Digital Certificates in Metrology Based on the Digital Syntax (DX)
 - 5.1 Digital Calibration Request (DCR)
 - 5.2 Digital Calibration Answer (DCA)
 - 5.3 Digital Test Certificates (DTC)
 - 5.4 Digital Certificates for Reference Materials (DRM)
- 6 Further Developments in the Field of Digital Metrological Certificates
 - 6.1 NIST Development on Digital Certificates for Reference Materials (DRM)
- 7 Good Practice (GP)
 - 7.1 Status GP
 - 7.2 How are GPs Created and Established?
- 8 Implementation Strategies
 - 8.1 In the NMI
 - 8.2 In the Calibration Laboratory
 - 8.3 In Industry
- 9 Mutual Recognition Arrangement (MRA) Handling
 - 9.1 CIPM MRA
 - 9.2 ILAC MRA
- 10 Persistent Identifier
 - 10.1 Global Identification Features of Calibration and Measurement Items

- 10.2 Unique Identifiers of Calibration and Measurement Items
- 10.3 Further Development of the Strategy for a Unique Identifier
- 11 Quality of Data
 - 11.1 Results from GEMIMEG-II
- 12 Rules and Wording
 - 12.1 The Rulebook
 - 12.2 The Wording
- 13 Signatures and Security Mechanisms
 - 13.1 Human Readable Signatures
 - 13.2 Security Mechanisms
 - 13.2.1 Hash-Based Security Mechanisms
 - 13.2.2 Signature-Based Security Mechanisms
 - 13.2.3 XML-Embedded Security Mechanisms
- 14 The DCC in Different Environments
 - 14.1 The DCC in an Industrial Environment
 - 14.2 The DCC in an Accredited Environment
 - 14.3 The DCC in the NMI
- 15 The DCC Scheme / Validation
 - 15.1 Status DCC Scheme
 - 15.2 DCC Version 4.0 and DX
 - 15.3 DCC Subschemas
 - 15.4 Schematron
- 16 Traceability
 - 16.1 Traceability to the National Standard
 - 16.2 Traceability to Previous Calibrations